

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/088,458	LAAKSO ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Khai M. Nguyen	2687

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
see	attached		kn
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